

ON Semiconductor®

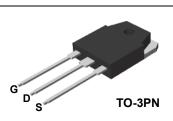
FQA13N50C-F109 N-Channel QFET[®] MOSFET 500 V, 13.5 A, 480 mΩ

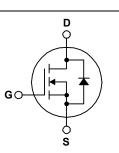
Description

These N-Channel enhancement mode power field effect transistors are produced using ON Semiconductor's proprietary, planar stripe, DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switched mode power supplies, active power factor correction, electronic lamp ballasts based on half bridge topology.

Features

- 13.5 A, 500 V, $R_{DS(on)}$ = 480 m Ω (Max.) @ V_{GS} = 10 V, I_D = 6.75 A
- Low Gate Charge (Typ. 43 nC)
- Low Crss (Typ. 20 pF)
- 100% Avalanche Tested
- Improved dv/dt Capability





Absolute Maximum Ratings T_C = 25°C unless otherwise noted.

Symbol	Parameter	FQA13N50C-F109	Unit	
V _{DSS}	Drain-Source Voltage	500	V	
I _D	Drain Current - Continuous ($T_C = 25^{\circ}C$)		13.5	А
	- Continuous (T _C = 100°C)		8.5	А
I _{DM}	Drain Current - Pulsed	(Note 1)	54	А
V _{GSS}	Gate-Source Voltage		± 30	V
E _{AS}	Single Pulsed Avalanche Energy (Note		860	mJ
I _{AR}	Avalanche Current	(Note 1)	13.5	А
E _{AR}	Repetitive Avalanche Energy	(Note 1)	21.8	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)		4.5	V/ns
PD	Power Dissipation ($T_C = 25^{\circ}C$)		218	W
	- Derate above 25°C		1.56	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150	°C
TI	Maximum Lead Temperature for Soldering,		300	°C
	1/8" from Case for 5 Seconds.		300	

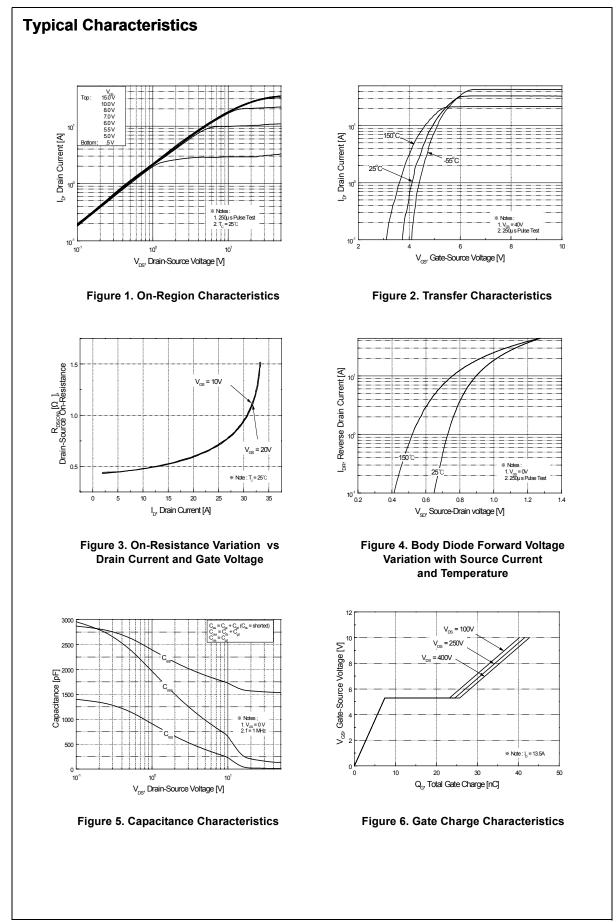
Thermal Characteristics

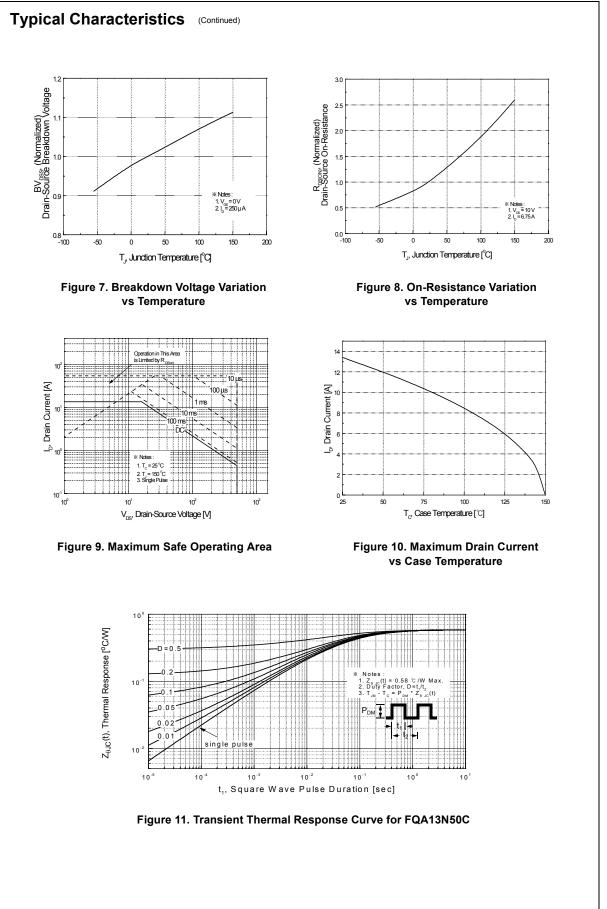
Symbol	Parameter	FQA13N50C-F109	Unit	
$R_{ extsf{ heta}JC}$	Thermal Resistance, Junction-to-Case, Max.	0.58	°C/W	
R_{\thetaJA}	Thermal Resistance, Junction-to-Ambient, Max.	40	°C/W	

Part Number FQA13N50C-F109		Top Mark FQA13N50C	Package	Package Packing Method Re		Size	Tape Width N/A		Quantity 30 units
			TO-3PN	Tube	N/A				
Electri	cal Chara	acteristics T _c	= 25°C unless othe	erwise noted.					
Symbol		Parameter		Test Conditions		Min.	Тур.	Max.	Unit
	aracteristic								
BV _{DSS}	Drain-Source Breakdown Voltage		$V_{CS} = 0$	V _{GS} = 0 V, I _D = 250 μA					V
ΔBV_{DSS}	Breakdown Voltage Temperature Coefficient					500			•
$/\Delta T_{J}$			I _D = 250	$I_D = 250 \ \mu A$, Referenced to $25^{\circ}C$			0.5		V/°C
I _{DSS}			V _{DS} = 5	V _{DS} = 500 V, V _{GS} = 0 V				1	μA
	Zero Gate V	/oltage Drain Current	V _{DS} = 4	$V_{\rm DS} = 400 \text{ V}, \text{ T}_{\rm C} = 125^{\circ}\text{C}$				10	μA
I _{GSSF}	Gate-Body	Leakage Current, Forw	ard V _{GS} = 3	V _{GS} = 30 V, V _{DS} = 0 V				100	nA
I _{GSSR}	Gate-Body	Leakage Current, Reve	erse V _{GS} = -	V_{GS} = -30 V, V_{DS} = 0 V				-100	nA
			1				1	1	I
	aracteristic		<u>\</u>			0.0			
V _{GS(th)}		hold Voltage	v _{DS} = V	/ _{GS} , I _D = 250 μA		2.0		4.0	V
R _{DS(on)}	Static Drain On-Resistar			0 V, I _D = 6.75 A			0.39	0.48	Ω
9 _{FS}	Forward Tra	ansconductance	V _{DS} = 4	0 V, I _D = 6.75 A			15		S
Dynam C _{iss}	ic Charact		V _{DS} = 2	5 V, V _{GS} = 0 V,			1580	2055	pF
C _{oss}	Output Cap	acitance		f = 1.0 MHz			180	235	pF
C _{rss}	Reverse Tra	ansfer Capacitance					20	25	pF
Switch	ing Charac	cteristics	i						
4	Turn-On De	lay Time	$V_{} = 2$	V _{DD} = 250 V, I _D = 13.5 A, Bo = 25 Q			25	60	ns
t _{d(on)}	Turn-On Ris						100	210	ns
		se Time		5.0			130	270	ns
t _r	Turn-Off De		R _G = 25	δΩ			150		
t _r t _{d(off)}	Turn-Off De Turn-Off Fa	lay Time			Note 4)		100	210	ns
t _r t _{d(off)}		lay Time II Time	R _G = 25	(1	Note 4)			210 56	ns nC
t _f	Turn-Off Fa	lay Time II Time Charge	R _G = 25	(1 .00 V, I _D = 13.5 A,	Note 4)		100	-	
t _r t _{d(off)} t _f Q _g Q _{gs}	Turn-Off Fa Total Gate C Gate-Source	lay Time II Time Charge e Charge	R _G = 25	(1 00 V, I _D = 13.5 A, 0 V	Note 4)		100 43 7.5	56	nC nC
t _r t _{d(off)} t _f Q _g Q _{gs} Q _{gd}	Turn-Off Fa Total Gate C Gate-Sourc Gate-Drain	lay Time II Time Charge e Charge	R _G = 25	(1 00 V, I _D = 13.5 A, 0 V (1			100 43	56 	nC
t_r $t_{d(off)}$ t_f Q_g Q_{gs} Q_{gd} Drain-S	Turn-Off Fa Total Gate (Gate-Sourc Gate-Drain	lay Time II Time Charge e Charge Charge	R _G = 25	(1 00 V, I _D = 13.5 A, 0 V (1 imum Ratings			100 43 7.5	56 	nC nC
$\begin{array}{c} t_r \\ t_{d(off)} \\ t_f \\ Q_g \\ Q_{gs} \\ Q_{gd} \\ \end{array}$	Turn-Off Fa Total Gate C Gate-Sourc Gate-Drain Source Dio Maximum C	lay Time II Time Charge e Charge Charge de Characteristic	$R_{G} = 25$ $V_{DS} = 4$ $V_{GS} = 1$ $R_{G} = 25$ $V_{GS} = 4$ $V_{GS} = 1$ $R_{G} = 1$	(1 00 V, I _D = 13.5 A, 0 V (1 imum Ratings ard Current			100 43 7.5 18.5	56 	nC nC nC
$\begin{array}{c} t_r \\ t_{d(off)} \\ t_f \\ Q_g \\ Q_{gs} \\ Q_{gd} \\ \end{array} \\ \hline \textbf{Drain-S} \\ I_S \\ I_{SM} \end{array}$	Turn-Off Fa Total Gate C Gate-Sourc Gate-Drain Source Dio Maximum C Maximum P	lay Time II Time Charge e Charge Charge de Characteristic continuous Drain-Sourc	$R_{G} = 25$ $V_{DS} = 4$ $V_{GS} = 1$ $R_{G} = 25$ $V_{GS} = 1$ $R_{G} = 1$ $R_{G} = 1$	(1 00 V, I _D = 13.5 A, 0 V (1 imum Ratings ard Current			100 43 7.5 18.5	56 13	nC nC nC
$\begin{array}{c} t_r \\ t_{d(off)} \\ t_f \\ Q_g \\ Q_{gs} \\ Q_{gd} \\ \end{array}$	Turn-Off Fa Total Gate C Gate-Sourc Gate-Drain Source Dio Maximum C Maximum P Drain-Sourc	lay Time II Time Charge e Charge Charge de Characteristic Continuous Drain-Source Pulsed Drain-Source Di	$R_{G} = 25$ $V_{DS} = 4$ $V_{GS} = 1$ $V_{GS} = 1$ $V_{GS} = 1$ $V_{GS} = 0$ $V_{GS} = 0$	(1 00 V, I _D = 13.5 A, 0 V (1 imum Ratings ard Current urrent		 	100 43 7.5 18.5 	56 13 52	nC nC nC A A

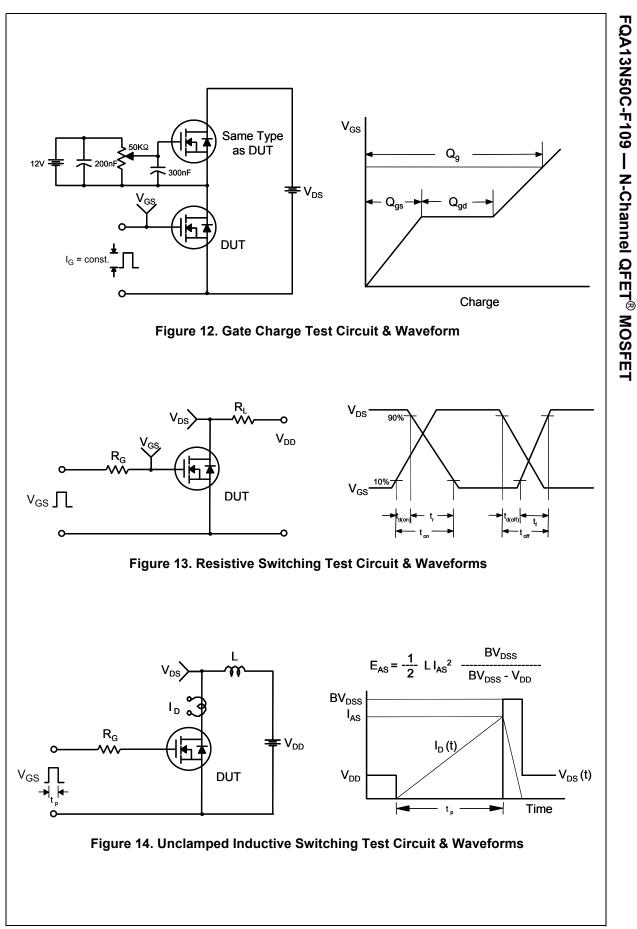
Notes:

1. Repetitive rating : pulse-width limited by maximum junction temperature. 2. L = 5.6 mH, I_{AS} = 13.5 A, V_{DD} = 50 V, R_G = 25 Ω , starting T_J = 25°C. 3. I_{SD} ≤ 13.5 A, di/dt ≤ 200 A/µs, V_{DD} ≤ BV_{DSS}, starting T_J = 25°C. 4. Essentially independent of operating temperature

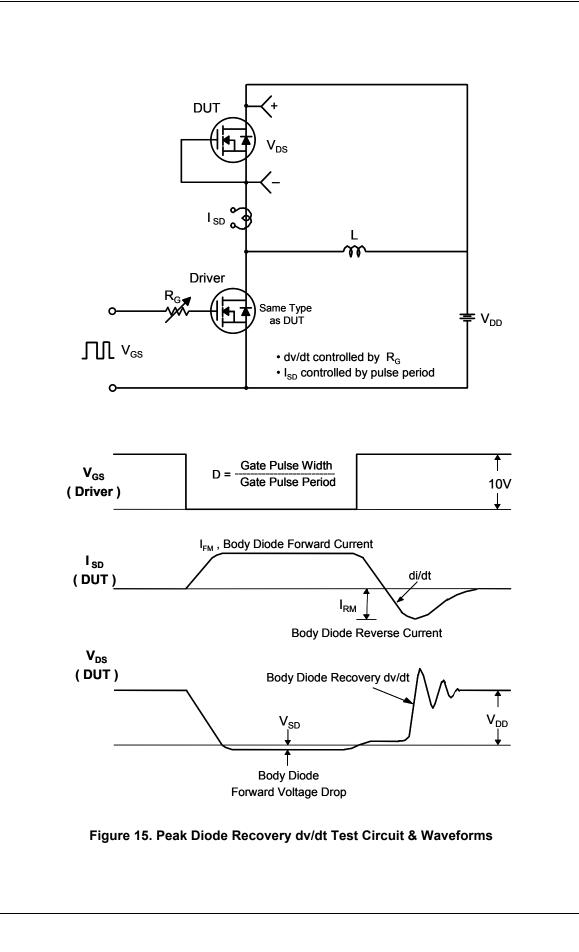


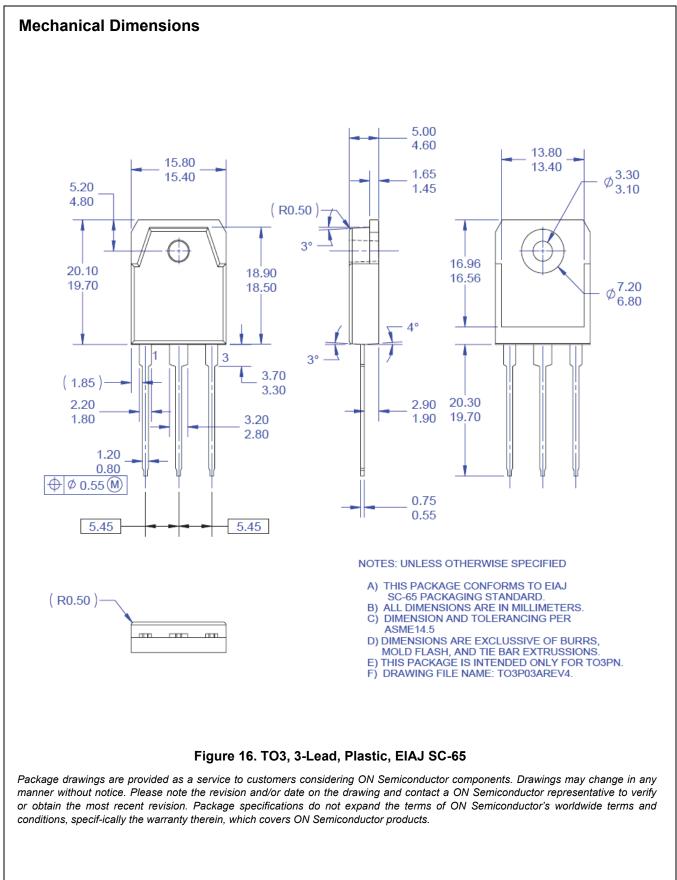


FQA13N50C-F109 — N-Channel QFET® MOSFET



FQA13N50C





ON Semiconductor and are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at <u>www.onsemi.com/site/pdf/Patent-Marking.pdf</u>. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor haves, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such uninten

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor 19521 E. 32nd Pkwy, Aurora, Colorado 80011 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com N. American Technical Support: 800–282–9855 Toll Free USA/Canada Europe, Middle East and Africa Technical Support: Phone: 421 33 790 2910

Japan Customer Focus Center Phone: 81–3–5817–1050 ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative